AUTOMOTIVE GRADE

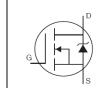


AUIRFR3710Z

S

Features

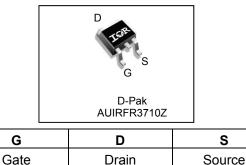
- Advanced Process Technology •
- Ultra Low On-Resistance •
- 175°C Operating Temperature
- Fast Switching •
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



G

HEXFET®	Power	MOSF	ΕT

V _{DSS}	100V
R _{DS(on)} max.	18mΩ
D (Silicon Limited)	56A
D (Package Limited)	42A



Descripti	on
Descripti	υn

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

Booo nort number	Dookogo Turo	Standard Pack		Orderable Part Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number	
AUIRFR3710Z	D. Dak	Tube	75	AUIRFR3710Z	
AUIKER3/ IUZ	D-Pak	Tape and Reel Left	3000	AUIRFR3710ZTRL	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	56	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	39	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	42	A
I _{DM}	Pulsed Drain Current ①	220	
P _D @T _C = 25°C	Maximum Power Dissipation	140	W
	Linear Derating Factor	0.95	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS} Single Pulse Avalanche Energy (Thermally Limited) 2 150			
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value 6	200	mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	A
E _{AR}	Repetitive Avalanche Energy S		mJ
TJ	Operating Junction and	-55 to + 175	
T _{STG}	T _{STG} Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Symbol Parameter		Max.	Units
R _{θJC}	Junction-to-Case ®		1.05	
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount) 🗇		50	°C/W
$R_{ heta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

*Qualification standards can be found at www.infineon.com



AUIRFR3710Z

Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	100			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.088		V/°C	Reference to 25°C, $I_D = 1mA$
R _{DS(on)}	Static Drain-to-Source On-Resistance		15	18	mΩ	V _{GS} = 10V, I _D = 33A
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	V _{DS} = V _{GS} , I _D = 250μA
gfs	Forward Trans conductance	39			S	V _{DS} = 25V, I _D = 33A ③
1	Drain-to-Source Leakage Current			20		V _{DS} = 100V, V _{GS} = 0V
IDSS				250	μA	V _{DS} = 100V,V _{GS} = 0V,T _J =125°C
I _{GSS}	Gate-to-Source Forward Leakage Gate-to-Source Reverse Leakage			200	5	V _{GS} = 20V
				-200	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q _g	Total Gate Charge		69	100		I _D = 33A
Q_{gs}	Gate-to-Source Charge		15		nC	V _{DS} = 80V
Q_{gd}	Gate-to-Drain Charge		25			V _{GS} = 10V③
t _{d(on)}	Turn-On Delay Time		14			$V_{DD} = 50V$
t _r	Rise Time		43		-	I _D = 33A
t _{d(off)}	Turn-Off Delay Time		53		ns	$R_{G} = 6.8\Omega$
t _f	Fall Time		42			V _{GS} = 10V③
L _D	Internal Drain Inductance		4.5		nH	Between lead, 6mm (0.25in.)
L _S	Internal Source Inductance		7.5		1111	from package
C _{iss}	Input Capacitance		2930			V _{GS} = 0V
C _{oss}	Output Capacitance		290			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		180		pF	<i>f</i> = 1.0MHz
C _{oss}	Output Capacitance		1200		рі	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
C _{oss}	Output Capacitance		180			$V_{GS} = 0V, V_{DS} = 80V f = 1.0MHz$
C _{oss eff.}	Effective Output Capacitance		430			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V \oplus$
Diode Chara	cteristics					
	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current (Body Diode)			56		MOSFET symbol showing the
	Pulsed Source Current			220	- Δ	integral reverse

220 I_{SM} (Body Diode) ① V_{SD} Diode Forward Voltage 1.3 V 35 53 **Reverse Recovery Time** ns lrr Q_{rr} Reverse Recovery Charge 62 nC 41

Notes:

t_{on}

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

© Limited by T_{Jmax} , starting $T_J = 25^{\circ}$ C, L = 0.28mH, $R_G = 25\Omega$, $I_{AS} = 33A$, $V_{GS} = 10V$. Part not recommended for use above this value.

③ Pulse width \leq 1.0ms; duty cycle \leq 2%.

Forward Turn-On Time

 \oplus C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}

 $\hfill S$ Limited by T_{Jmax} , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

⑦ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

 \circledast R_{θ} is measured at T_J approximately 90°C.

p-n junction diode.

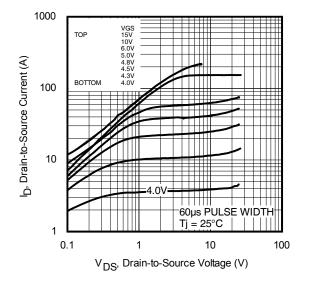
di/dt = 100A/µs ③

Intrinsic turn-on time is negligible (turn-on is dominated by $L_{s}+L_{D}$)

T_J = 25°C,I_S = 33A, V_{GS} = 0V ③

 $T_J = 25^{\circ}C$, $I_F = 33A$, $V_{DD} = 50V$





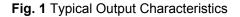


Fig. 2 Typical Output Characteristics

 V_{DS} , Drain-to-Source Voltage (V)

4.0

⁻60µs PULSE WIDTH Tj = 175°C

100

10

1000

l_D, Drain-to-Source Current (A) 1 01 01 01

0.1

0.1

TOP

воттом

VGS 15V 10V 6.0V 5.0V 4.8V 4.5V 4.3V 4.0V

1

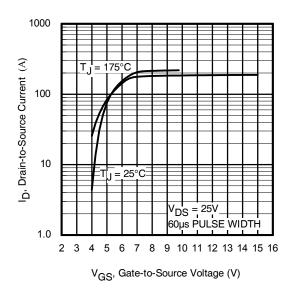


Fig. 3 Typical Transfer Characteristics

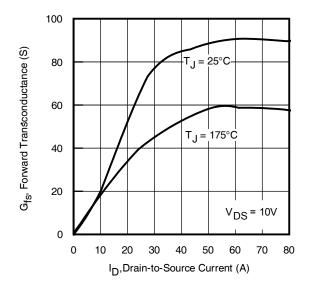
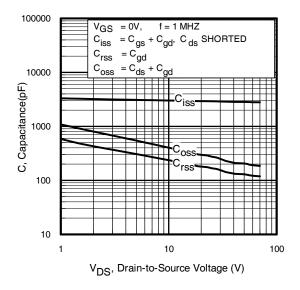
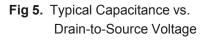


Fig. 4 Typical Forward Trans conductance Vs. Drain Current







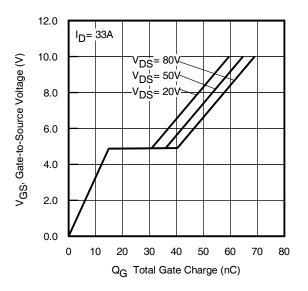


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

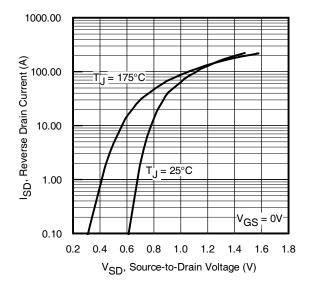


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

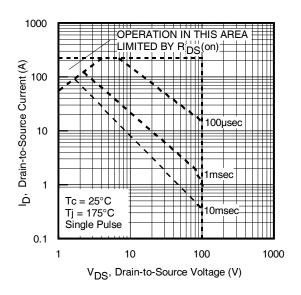
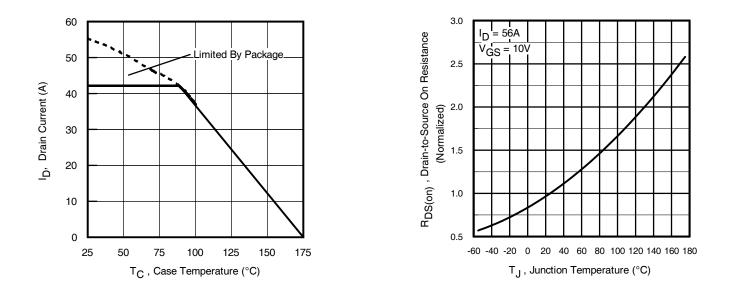
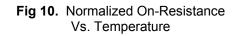


Fig 8. Maximum Safe Operating Area









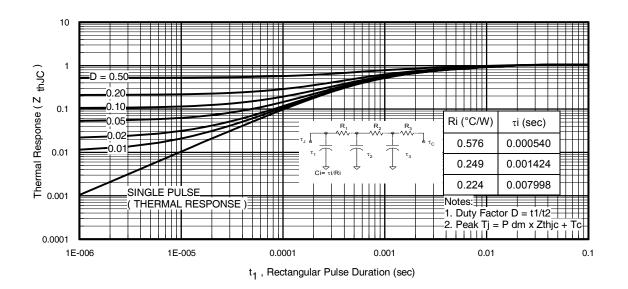


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

AUIRFR3710Z

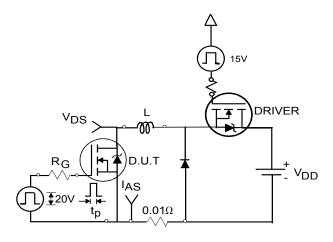


Fig 12a. Unclamped Inductive Test Circuit

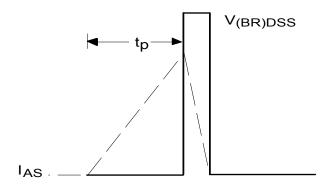


Fig 12b. Unclamped Inductive Waveforms

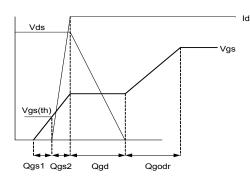


Fig 13a. Gate Charge Waveform

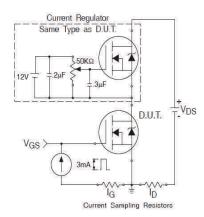
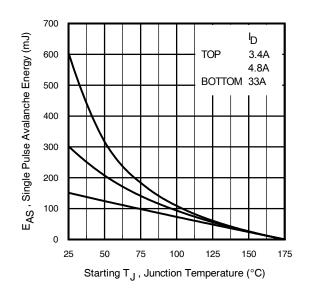
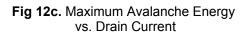


Fig 13b. Gate Charge Test Circuit





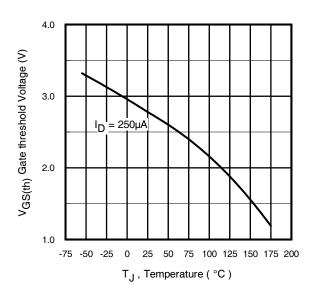


Fig 14. Threshold Voltage Vs. Temperature



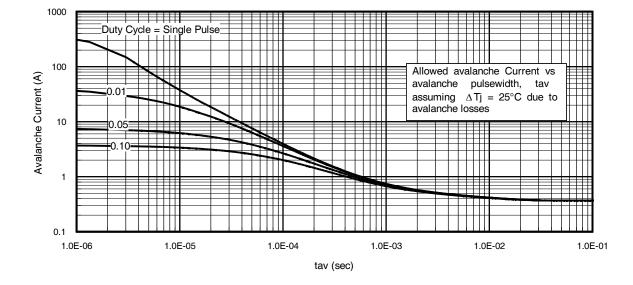
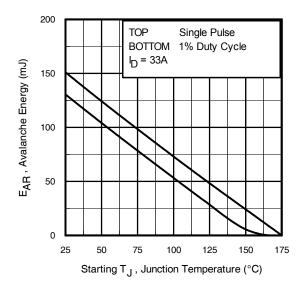
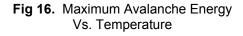


Fig 15. Typical Avalanche Current Vs. Pulse width





Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = $t_{av} \cdot f$

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \textbf{P}_{D (ave)} &= 1/2 \; (\; 1.3 \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T / \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \; \textbf{[} 1.3 \cdot \textbf{BV} \cdot \textbf{Z}_{th} \textbf{]} \\ \textbf{E}_{AS (AR)} &= \textbf{P}_{D (ave)} \cdot \textbf{t}_{av} \end{split}$$



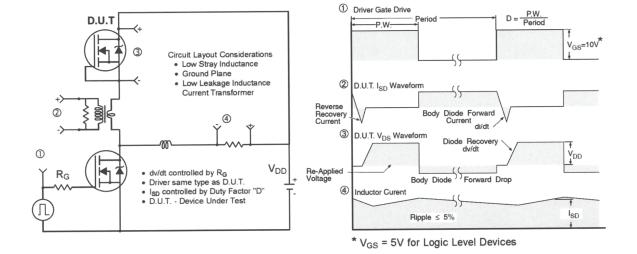


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

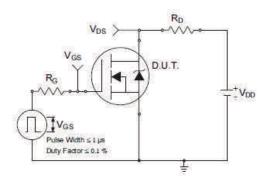


Fig 18a. Switching Time Test Circuit

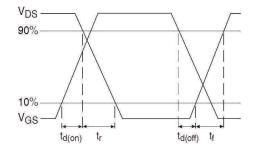
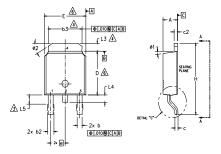


Fig 18b. Switching Time Waveforms

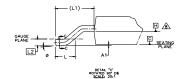


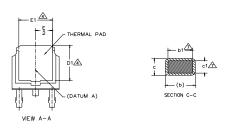
AUIRFR3710Z

D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].

A- LEAD DIMENSION UNCONTROLLED IN L5.

- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.

 $\underline{\&}$ - DATUM A & B TO BE DETERMINED AT DATUM PLANE H. 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

0						
S Y M		N O T				
В	MILLIM	ETERS	INC	INCHES		
0 L	MIN.	MAX.	MIN.	MAX.	Ē	
A	2.18	2.39	.086	.094		
A1	-	0.13	-	.005		
b	0.64	0.89	.025	.035		
ь1	0.65	0.79	.025	.031	7	
b2	0.76	1.14	.030	.045		
b3	4.95	5.46	.195	.215	4	
с	0.46	0.61	.018	.024		
c1	0.41	0.56	.016	.022	7	
c2	0.46	0.89	.018	.035		
D	5.97	6.22	.235	.245	6	
D1	5.21	-	.205	-	4	
Е	6.35	6.73	.250	.265	6	
E1	4.32	-	.170	-	4	
е	2.29 BSC		.090	BSC		
н	9.40	10.41	.370	.410		
L	1.40	1.78	.055	.070		
L1	2.74	BSC	.108	REF.		
L2	0.51	BSC	.020	BSC		
L3	0.89	1.27	.035	.050	4	
L4	-	1.02	-	.040		
L5	1.14	1.52	.045	.060	3	
ø	0.	10 °	0.	10°		
ø1	0.	15°	0.	15*		
ø2	25*	35*	25*	35*		

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

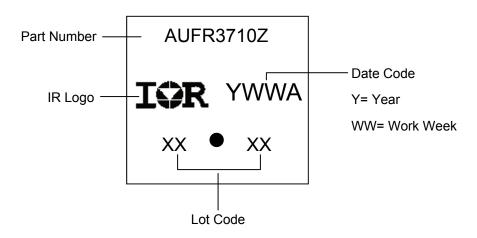
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

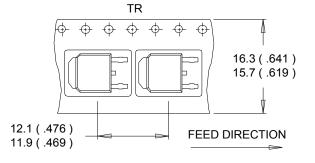
4.- COLLECTOR

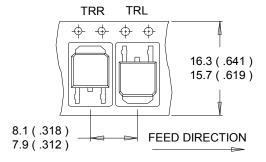
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

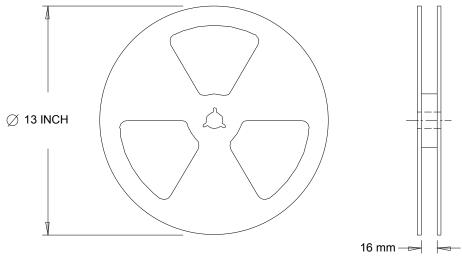
D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

			Automotive (per AEC-Q101)			
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture Sensitivity Level		D-Pak	MSL1			
		Class M4 [†]				
	Machine Model	AEC-Q101-002				
	Liver on Dedu Medel	Class H1C [†]				
ESD	Human Body Model	AEC-Q101-001				
		Class C3 [†]				
	Charged Device Model	AEC-Q101-005				
RoHS Compliant			Yes			

+ Highest passing voltage.

Revision History

Date	Comments		
11/23/2015	Updated datasheet with corporate template		
11/23/2015	Corrected ordering table on page 1.		

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